

# SLD20P10T/SLP20P10T

## 100V P -Channel MOSFET

### General Description

This Power MOSFET is produced using Msemitek's advanced TRENCH technology.

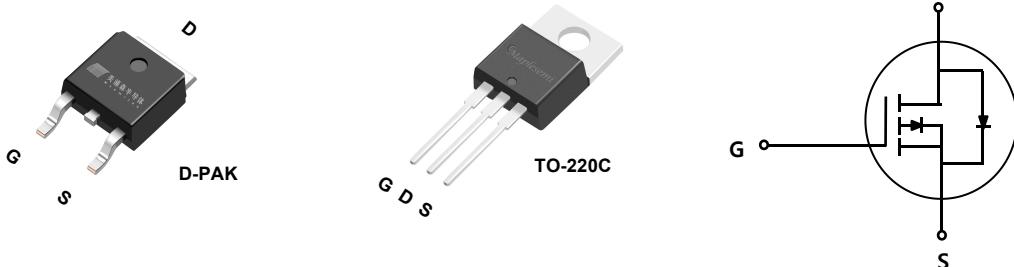
This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

### Application

- PWM Application
- Load Switch
- Power Management

### Features

- N-Channel:-100V -20A
- $R_{DS(on)Typ} = 59m\Omega @ V_{GS} = 10 \text{ V}$
- Very Low On-resistance  $R_{DS(ON)}$
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	SLD20P10T/SLP20P10T	Units
$V_{DSS}$	Drain-Source Voltage	-100	V
$I_D$	Drain Current    - Continuous ( $T_C = 25^\circ\text{C}$ ) - Continuous ( $T_C = 100^\circ\text{C}$ )	-20 -17	A
$I_{DM}$	Drain Current - Pulsed	(Note 1) -80	A
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulsed Avalanche Energy	(Note 2) 42	mJ
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ ) Power Dissipation ( $T_C = 100^\circ\text{C}$ )	102 -	W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.22	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to ambient	91	$^\circ\text{C}/\text{W}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature.

## Electrical Characteristics

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-100	--	--	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = -100 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	-1.0	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
$I_{\text{GSSR}}$	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -20 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

### On Characteristics

$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = -250 \mu\text{A}$	-1.5	-2	-2.5	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = -10 \text{ V}, I_D = -10 \text{ A} @ T_j = 25^\circ\text{C}$	--	59	70	$\text{m}\Omega$
		$V_{\text{GS}} = -10 \text{ V}, I_D = -10 \text{ A} @ T_j = 150^\circ\text{C}$	--	120	150	$\text{m}\Omega$

### Dynamic Characteristics

$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = -50 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	2859	-	pF
$C_{\text{oss}}$	Output Capacitance		--	93	-	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	68	-	pF

### Switching Characteristics

$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{GS}} = -10 \text{ V}, V_{\text{DS}} = -50 \text{ V}, R_L = 2.7 \Omega, I_D = -10 \text{ A}$	--	8	--	ns
$t_r$	Turn-On Rise Time		--	27	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	115	--	ns
$t_f$	Turn-Off Fall Time		--	77	--	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = -50 \text{ V}, I_D = -20 \text{ A}, V_{\text{GS}} = -10 \text{ V}$	--	53	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	12	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	10	--	nC

### Drain-Source Diode Characteristics and Maximum Ratings

$I_s$	Maximum Continuous Drain-Source Diode Forward Current	--	--	-20	A
$I_{\text{SM}}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	-80	A
$V_{\text{SD}}$	Drain to Source Diode Forward Voltage, $V_{\text{GS}} = 0 \text{ V}, I_{\text{SD}} = -10 \text{ A}, T_J = 25^\circ\text{C}$	--	-0.9	-1.3	V
$T_{\text{rr}}$	Reverse recovery time, $I_F = -10 \text{ A}, \Delta I_F / dt = 100 \text{ A}/\mu\text{s}$		36		ns
$Q_{\text{rr}}$	Reverse recovery charge, $I_F = -10 \text{ A}, \Delta I_F / dt = 100 \text{ A}/\mu\text{s}$		40		nC

#### Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 0.5\%$

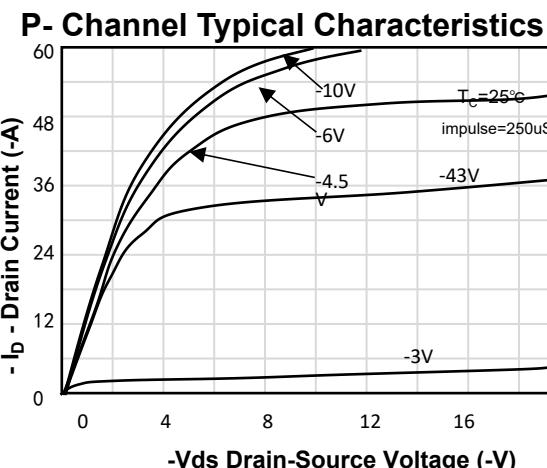


Figure 1. On-Region Characteristics

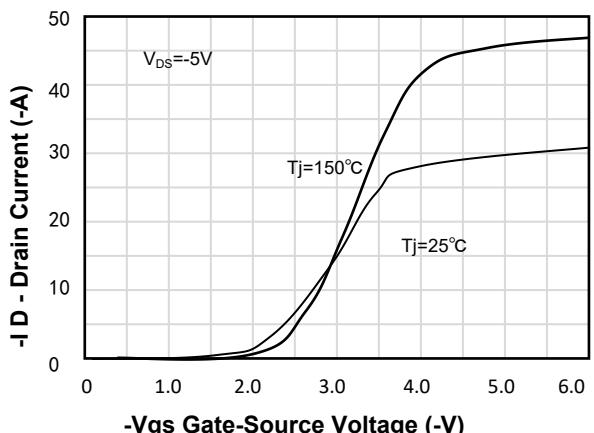


Figure 2. Transfer Characteristics

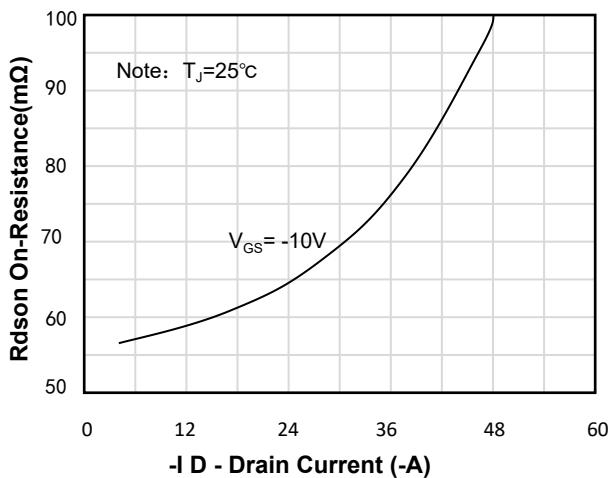


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

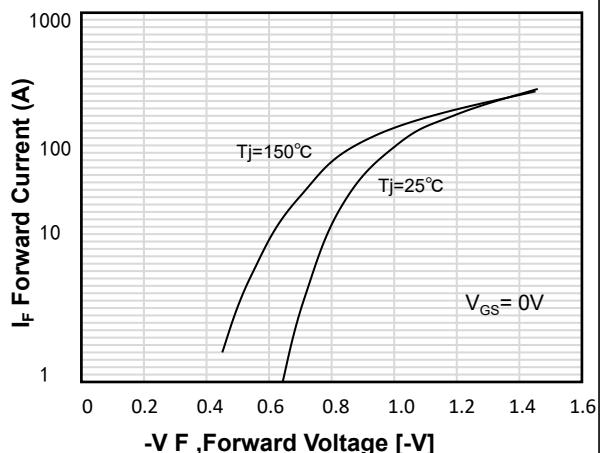


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

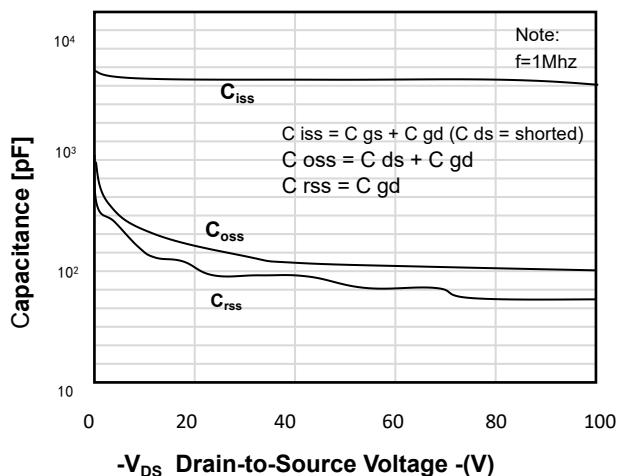


Figure 5. Capacitance Characteristics

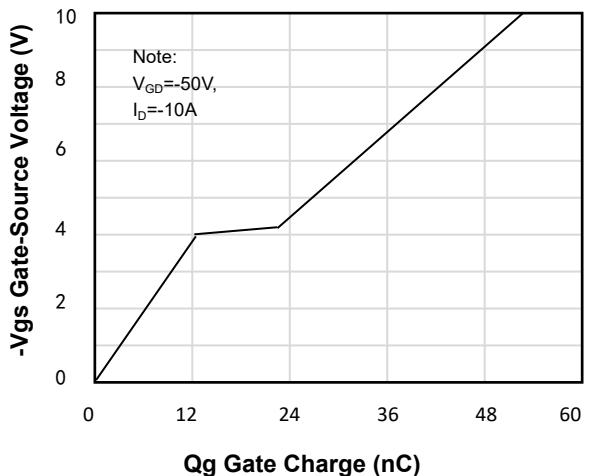


Figure 6. Gate Charge Characteristics

## P-Channel Typical Characteristics

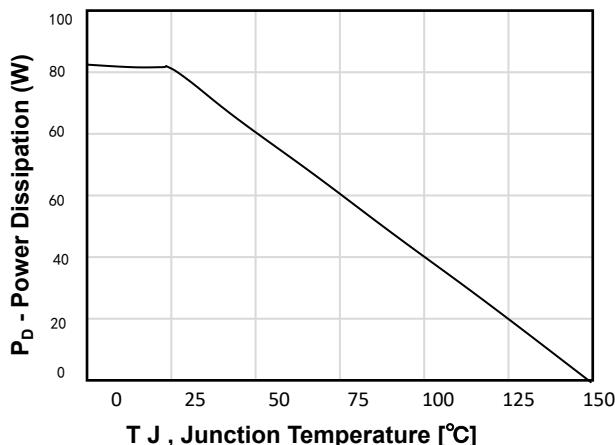


Figure 7. Power Dissipation Variation vs Temperature

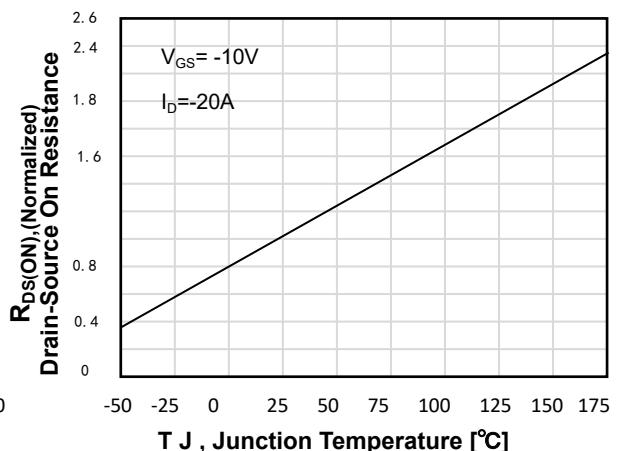


Figure 8. On-Resistance Variation vs Temperature

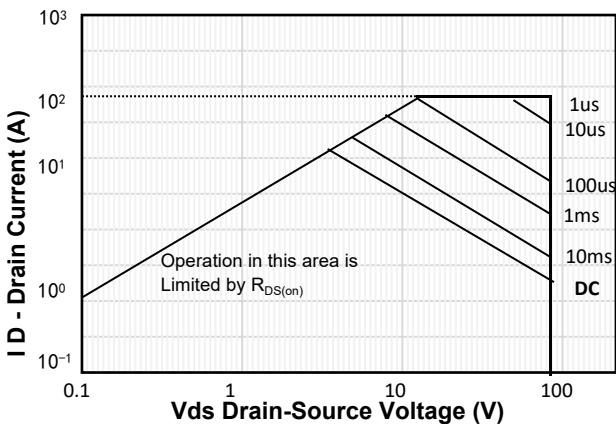


Figure 9. Maximum Safe Operating Area

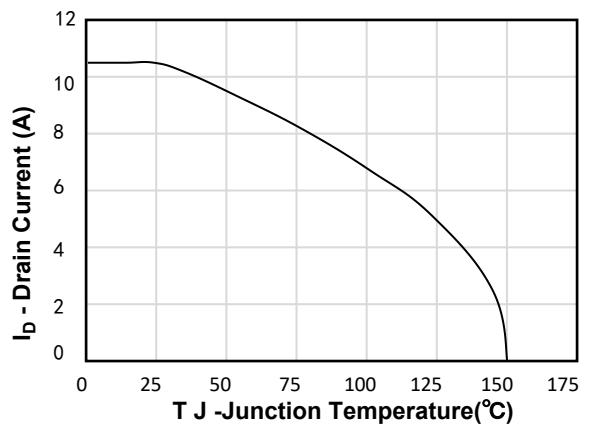


Figure 10. Maximum Continuous Drain Current vs Temperature

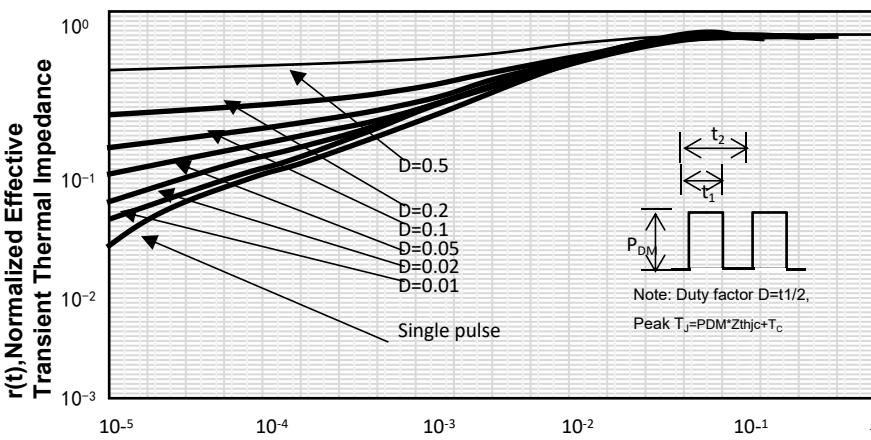
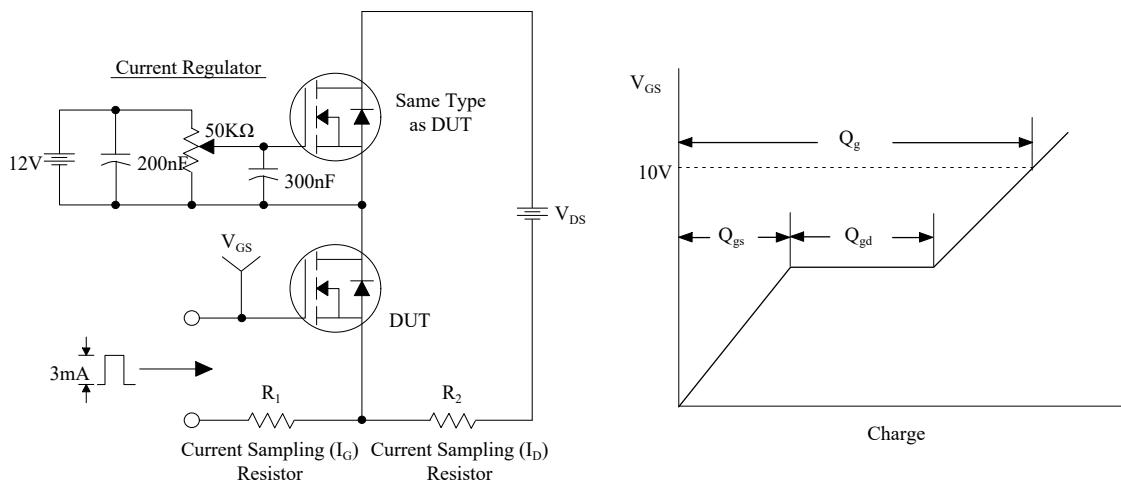
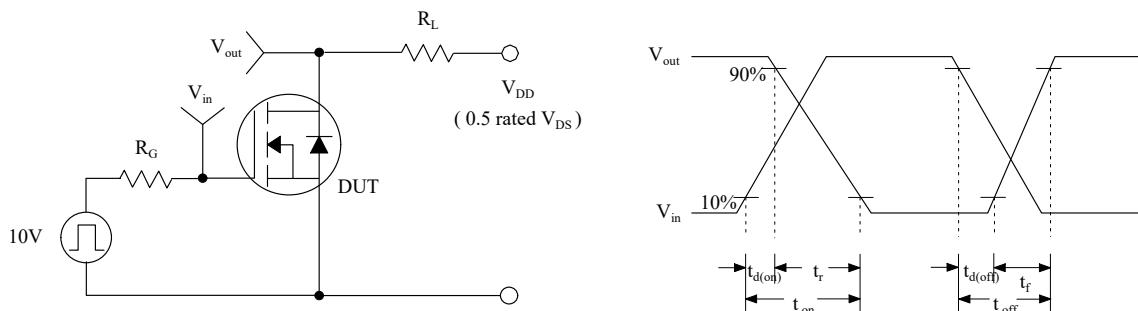


Figure 11. Transient Thermal Response Curve

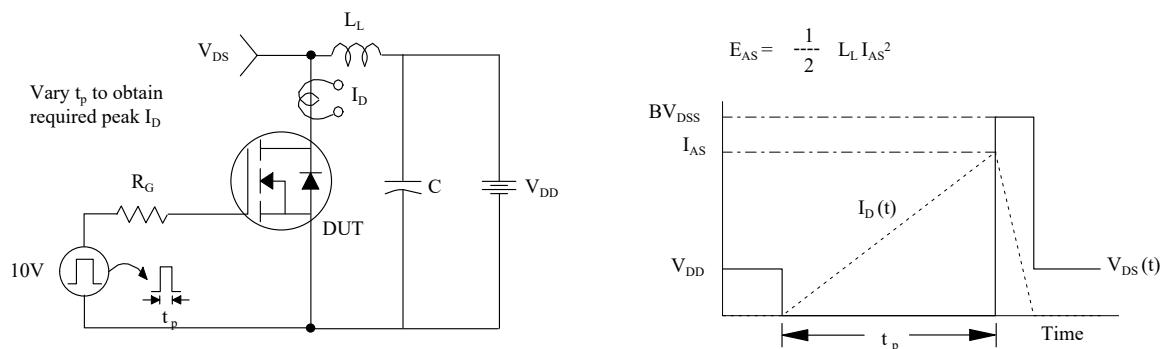
## Gate Charge Test Circuit & Waveform



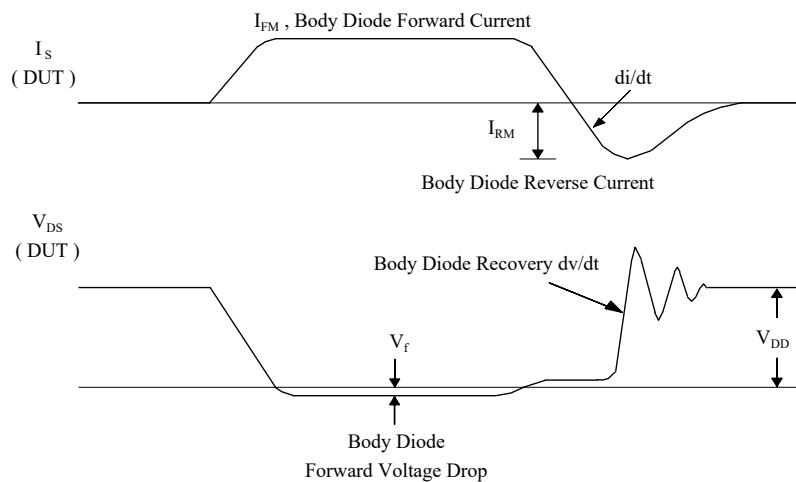
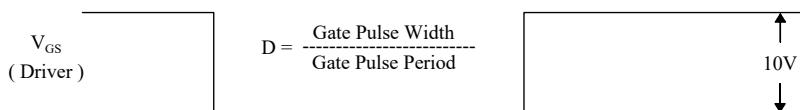
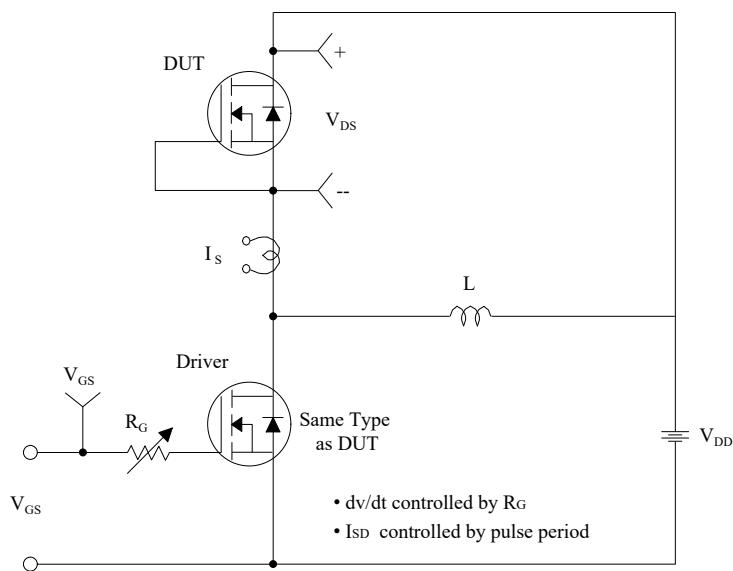
## Resistive Switching Test Circuit & Waveforms



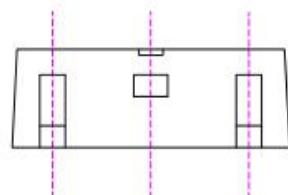
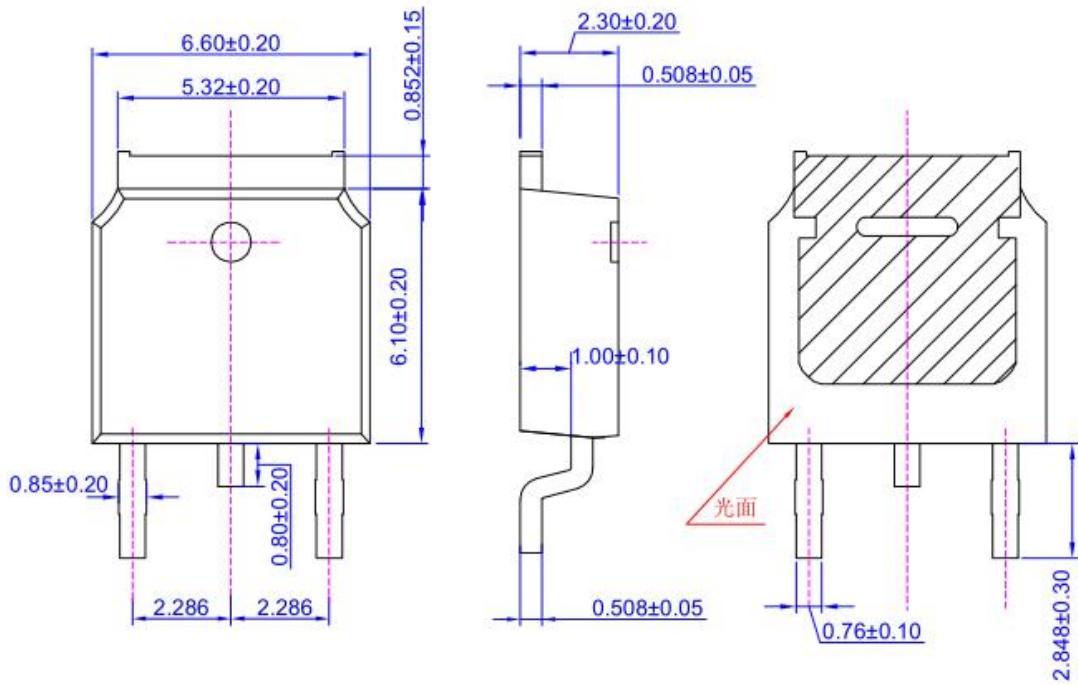
## Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



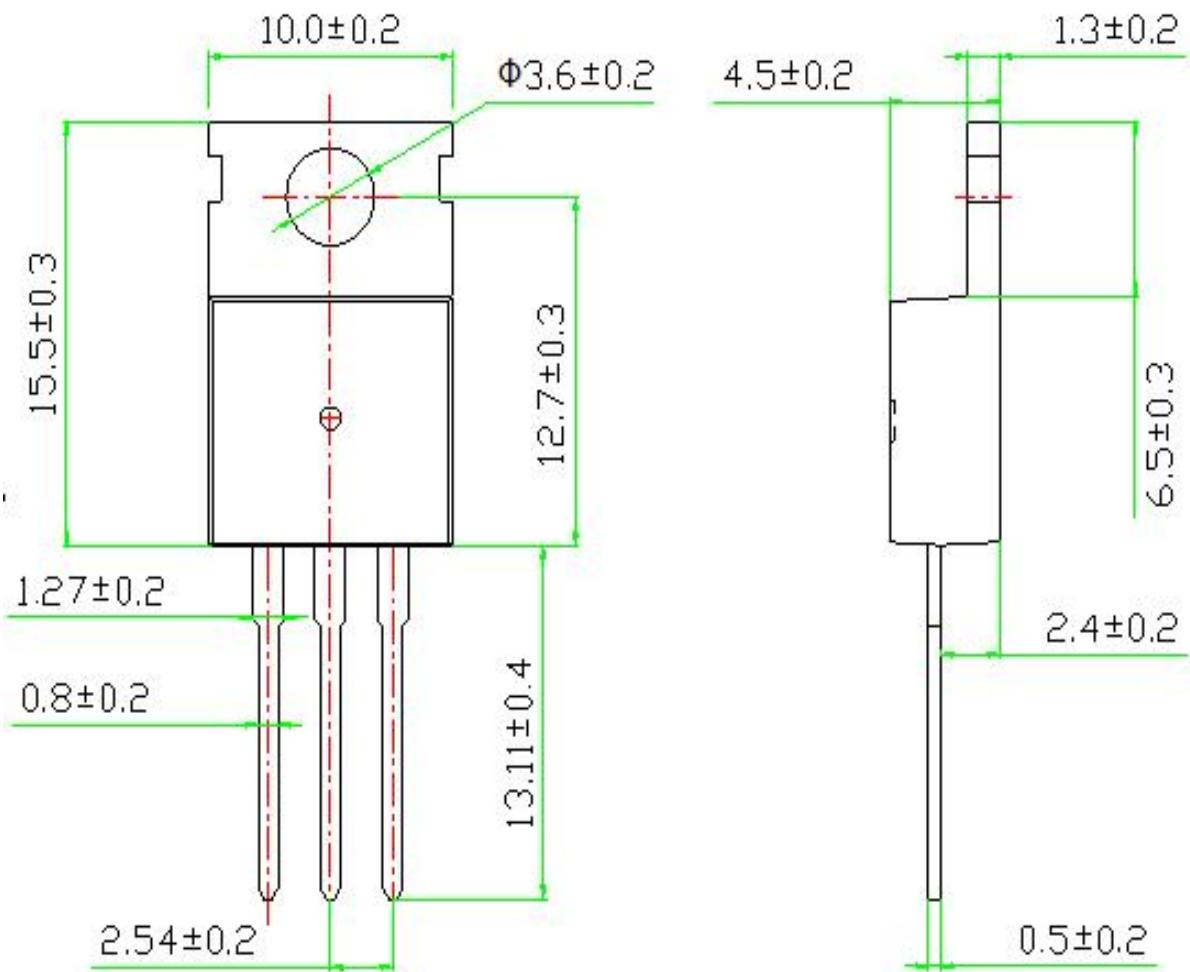
## TO-252 OUTLINE



### NOTE:

- 1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8
- 2.Undeclared tolerance±0.25,Unmarked filletRmax=0.25

## TO-220C OUTLINE



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